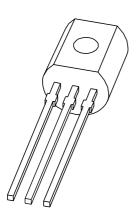
# **DISCRETE SEMICONDUCTORS**

# DATA SHEET



# PBSS5350S50 V low V<sub>CEsat</sub> PNP transistor

Product data sheet Supersedes data of 2001 Nov 19 2004 Aug 20



# 50 V low V<sub>CEsat</sub> PNP transistor

#### **PBSS5350S**

#### **FEATURES**

- High power dissipation (830 mW)
- · Ultra low collector-emitter saturation voltage
- 3 A continuous current
- · High current switching
- Improved device reliability due to reduced heat generation.

#### **APPLICATIONS**

- · Medium power switching and muting
- · Linear regulators
- DC/DC convertor
- · Supply line switching circuits
- Battery management applications
- · Strobe flash units
- Heavy duty battery powered equipment (motor and lamp drivers).

#### **DESCRIPTION**

PNP low  $V_{\text{CEsat}}$  transistor in a SOT54 plastic package. NPN complement: PBSS4350S.

#### **MARKING**

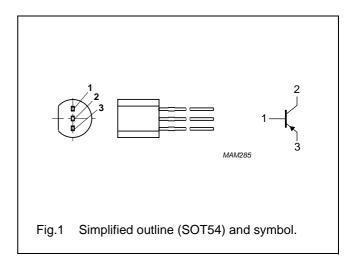
TYPE NUMBER	MARKING CODE
PBSS5350S	S5350S

#### **QUICK REFERENCE DATA**

SYMBOL	PARAMETER	MAX.	UNIT
V <sub>CEO</sub>	collector-emitter voltage	-50	V
I <sub>C</sub>	collector current (DC)	-3	Α
I <sub>CM</sub>	peak collector current	-5	Α
R <sub>CEsat</sub>	equivalent on-resistance	<150	mΩ

#### **PINNING**

PIN	DESCRIPTION
1	base
2	collector
3	emitter



#### **LIMITING VALUES**

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>CBO</sub>	collector-base voltage	open emitter	_	-60	V
$V_{CEO}$	collector-emitter voltage	open base	-	-50	V
$V_{EBO}$	emitter-base voltage	open collector	_	-6	V
I <sub>C</sub>	collector current (DC)		_	-3	Α
I <sub>CM</sub>	peak collector current		_	<b>-5</b>	Α
I <sub>BM</sub>	peak base current		_	-1	Α
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> ≤ 25 °C; note 1	-	830	mW
T <sub>stg</sub>	storage temperature		-65	+150	°C
Tj	junction temperature		_	150	°C
T <sub>amb</sub>	operating ambient temperature		-65	+150	°C

#### Note

1. Device mounted on a printed-circuit board, single sided copper, tinplated and standard footprint.

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#### THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R <sub>th j-a</sub>	thermal resistance from junction to ambient	in free air; note 1	150	K/W

#### Note

1. Device mounted on a printed-circuit board, single sided copper, tinplated and standard footprint.

#### **CHARACTERISTICS**

 $T_{amb}$  = 25 °C unless otherwise specified.

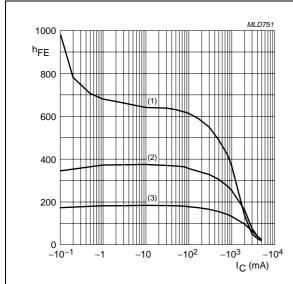
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I <sub>CBO</sub>	collector-base cut-off current	$V_{CB} = -50 \text{ V}; I_E = 0$	_	_	-100	nA
		$V_{CB} = -50 \text{ V}; I_E = 0; T_j = 150 ^{\circ}\text{C}$	_	_	-50	μΑ
I <sub>EBO</sub>	emitter-base cut-off current	$V_{EB} = -5 \text{ V}; I_C = 0$	_	_	-100	nA
h <sub>FE</sub>	DC current gain	$V_{CE} = -2 \text{ V}; I_{C} = -500 \text{ mA}$	200	_	_	
		$V_{CE} = -2 \text{ V}; I_{C} = -1 \text{ A}; \text{ note } 1$	200	_	_	
		$V_{CE} = -2 \text{ V}; I_{C} = -2 \text{ A}; \text{ note 1}$	100	_	_	
V <sub>CEsat</sub>	collector-emitter saturation	$I_C = -500 \text{ mA}; I_B = -50 \text{ mA}$	_	_	-100	mV
	voltage	$I_C = -1 \text{ A}; I_B = -50 \text{ mA}$	_	_	-180	mV
		$I_C = -2 \text{ A}$ ; $I_B = -200 \text{ mA}$ ; note 1	_	_	-300	mV
R <sub>CEsat</sub>	equivalent on-resistance	$I_C = -2 \text{ A}$ ; $I_B = -200 \text{ mA}$ ; note 1	_	120	<150	mΩ
V <sub>BEsat</sub>	base-emitter saturation voltage	$I_C = -2 \text{ A}$ ; $I_B = -200 \text{ mA}$ ; note 1	_	_	-1.2	V
V <sub>BE</sub>	base-emitter turn-on voltage	$V_{CE} = -2 \text{ V}; I_{C} = -1 \text{ A}; \text{ note 1}$	_	_	-1.1	V
f <sub>T</sub>	transition frequency	$I_C = -100 \text{ mA}; V_{CE} = -5 \text{ V}; f = 100 \text{ MHz}$	100	_	_	MHz
C <sub>c</sub>	collector capacitance	$V_{CB} = -10 \text{ V}; I_E = I_e = 0; f = 1 \text{ MHz}$	_	_	40	pF

#### Note

1. Pulse test:  $t_p \leq 300~\mu s;~\delta \leq 0.02.$ 

# 50 V low V<sub>CEsat</sub> PNP transistor

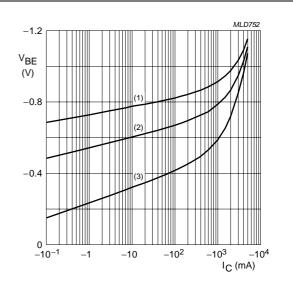
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 $V_{CE} = -2 \text{ V}.$ 

- (1)  $T_{amb} = 150 \, ^{\circ}C$ .
- (2)  $T_{amb} = 25 \, ^{\circ}C$ .
- (3)  $T_{amb} = -55 \, ^{\circ}C$ .

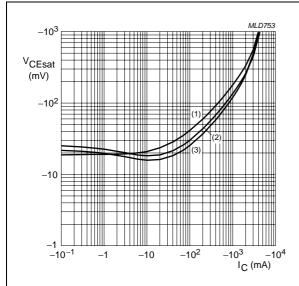
Fig.2 DC current gain as a function of collector current; typical values.



 $V_{CE} = -2 V$ .

- (1)  $T_{amb} = -55 \, ^{\circ}C$ .
- (2)  $T_{amb} = 25 \, ^{\circ}C$ .
- (3)  $T_{amb} = 150 \, ^{\circ}C$ .

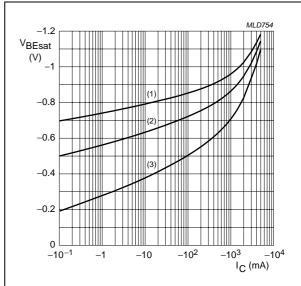
Fig.3 Base-emitter voltage as a function of collector current; typical values.



 $I_{\rm C}/I_{\rm B} = 20.$ 

- (1)  $T_{amb} = 150 \, ^{\circ}C$ .
- (2)  $T_{amb} = 25 \, ^{\circ}C$ .
- (3)  $T_{amb} = -55 \, ^{\circ}C$ .

Fig.4 Collector-emitter saturation voltage as a function of collector current; typical values.



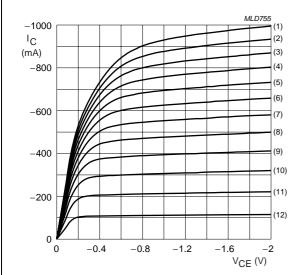
 $I_{\rm C}/I_{\rm B} = 20.$ 

- (1)  $T_{amb} = -55 \, ^{\circ}C$ .
- (2)  $T_{amb} = 25 \, ^{\circ}C$ .
- (3)  $T_{amb} = 150 \, ^{\circ}C$ .

Fig.5 Base-emitter saturation voltage as a function of collector current; typical values.

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 $T_{amb}$  = 25 °C.

(1)  $I_B = -3.96 \text{ nA}$ .

(5)  $I_B = -2.64 \text{ nA}$ .

(9)  $I_B = -1.32 \text{ nA}.$ 

(2)  $I_B = -3.63 \text{ nA}.$ 

(6)  $I_B = -2.31 \text{ nA}.$ 

(10)  $I_B = -0.99 \text{ nA}$ .

(3)  $I_B = -3.30 \text{ nA}.$ 

(7)  $I_B = -1.98 \text{ nA}.$ 

(11)  $I_B = -0.66 \text{ nA}$ .

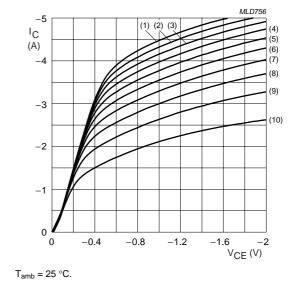
(4)  $I_B = -2.97 \text{ nA}.$ 

(8)  $I_B = -1.65 \text{ nA}.$ 

collector-emitter voltage; typical values.

(12)  $I_B = -0.33 \text{ nA}$ .

Collector current as a function of



(1)  $I_B = -250 \text{ mA}$ .

(5)  $I_B = -150 \text{ mA}.$ 

(9)  $I_B = -50 \text{ mA}.$ 

(2)  $I_B = -225 \text{ mA}.$ 

(6)  $I_B = -125 \text{ mA}.$ 

(10)  $I_B = -25 \text{ mA}$ .

(3)  $I_B = -200 \text{ mA}.$ (4)  $I_B = -175 \text{ mA}.$  (7)  $I_B = -100 \text{ mA}.$ (8)  $I_B = -75 \text{ mA}.$ 

Collector current as a function of collector-emitter voltage; typical values.

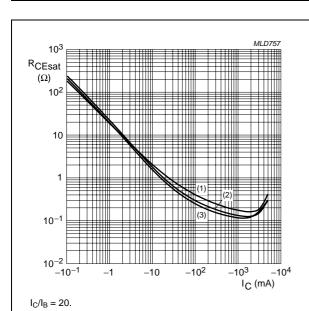


Fig.8 Collector-emitter equivalent on-resistance as a function of collector current; typical values.

(1)  $T_{amb} = 150 \,^{\circ}\text{C}$ . (2)  $T_{amb} = 25 \,^{\circ}\text{C}$ . (3)  $T_{amb} = -55 \,^{\circ}\text{C}$ .

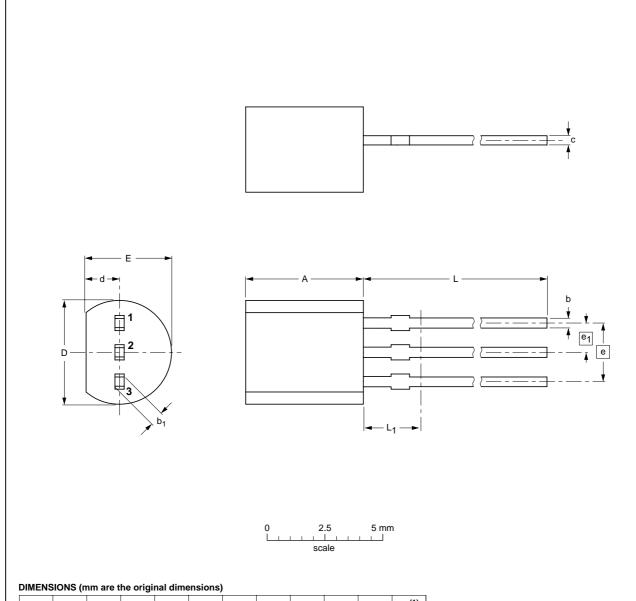
# 50 V low $V_{\text{CEsat}}$ PNP transistor

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#### **PACKAGE OUTLINE**

#### Plastic single-ended leaded (through hole) package; 3 leads

SOT54



UNIT	Α	b	b <sub>1</sub>	С	D	d	E	е	e <sub>1</sub>	L	L <sub>1</sub> <sup>(1)</sup> max.
mm	5.2 5.0	0.48 0.40	0.66 0.55	0.45 0.38	4.8 4.4	1.7 1.4	4.2 3.6	2.54	1.27	14.5 12.7	2.5

#### Note

1. Terminal dimensions within this zone are uncontrolled to allow for flow of plastic and terminal irregularities.

OUTLINE		REFER	EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	JEITA		PROJECTION 1550E DAT	
SOT54		TO-92	SC-43A			<del>-04-06-28</del> 04-11-16

## 50 V low V<sub>CEsat</sub> PNP transistor

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#### **DATA SHEET STATUS**

DOCUMENT STATUS <sup>(1)</sup>	PRODUCT STATUS <sup>(2)</sup>	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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#### **Contact information**

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Printed in The Netherlands R75/02/pp8 Date of release: 2004 Aug 20 Document order number: 9397 750 13638

